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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,691,101	11-1997	Ushirogouchi et al.	430/176
	В	US-			
	С	US-			
	D	US-			
	E	US-			
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U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

+		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
,	U	Kanda et al., "Advanced Microlithography Process with Chemical Shrink Technology", Advances in Resist Technology and PRocessing XVII, vol.3999 (2000), pg.881-889.
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